

### **AC250V Type (Which Meet Japanese Low)**

#### ■ Features

- 1. Chip monolitic ceramic capacitor for AC line.
- 2. A new monolithic structure for small, highcapacitance capable of operating at high-voltage
- 3. Sn-plated external electrodes realize good solderability.
- 4. Only for Reflow soldering.
- 5. Capacitance 0.01 to 0.1 uF for connecting lines and 470 to 4700 pF for connecting line to earth.



Noise suppression filters for switching power supplies, telephones, facsimiles, modems.

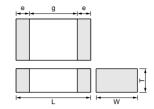
#### ■ Refference srandard

JIS C 5102

JIS C 5150

The standards of the electrical appliance and material safety law of Japan, separated table 4.





Part Number	Dimensions (mm)							
Part Number	L	W	T	e min.	g min.			
GA252D	5.7 ±0.4	2.8 ±0.3	2.0 ±0.3	0.3	3.5			
GA255D	5.7 ±0.4	5.0 ±0.4	2.0 ±0.3	0.3	3.5			

Part Number	Rated Voltage (V)	TC Code	Capacitance	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g (mm)	Electrode e (mm)
GA252DB3E2471MY02L	AC250 (r.m.s.)	В	470pF +20,-20%	5.7	2.8	2.0	3.5 min.	0.3 min.
GA252DB3E2102MY02L	AC250 (r.m.s.)	В	1000pF +20,-20%	5.7	2.8	2.0	3.5 min.	0.3 min.
GA252DB3E2222MY02L	AC250 (r.m.s.)	В	2200pF +20,-20%	5.7	2.8	2.0	3.5 min.	0.3 min.
GA252DB3E2472MY02L	AC250 (r.m.s.)	В	4700pF +20,-20%	5.7	2.8	2.0	3.5 min.	0.3 min.
GA252DB3E2103MY02L	AC250 (r.m.s.)	В	10000pF +20,-20%	5.7	2.8	2.0	3.5 min.	0.3 min.
GA252DB3E2223MY02L	AC250 (r.m.s.)	В	22000pF +20,-20%	5.7	2.8	2.0	3.5 min.	0.3 min.
GA252DB3E2473MY02L	AC250 (r.m.s.)	В	47000pF +20,-20%	5.7	2.8	2.0	3.5 min.	0.3 min.
GA255DB3E2104MY02L	AC250 (r.m.s.)	В	0.1μF +20,-20%	5.7	5.0	2.0	3.5 min.	0.3 min.

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### Specifications and Test Methods

No.	Ite	em	Specification	Test Method			
1	Operating Temperatu	ıre Range	−25 to +85°C	_			
2	Appearan	nce	No defects or abnormalities.	Visual inspection.			
3	Dimensio	ns	Within the specified dimensions.	Using calipers.			
4	4 Dielectric Strength		No defects or abnormalities.	No failure shall be observed when voltage as table is applied between the terminations for 60±1 s, provided the charge/discharge current is less than 50mA.    Nominal Capacitance   Test voltage			
5	Insulation F	Resistance	More than $2{,}000M\Omega$	The insulation resistance shall be measured with 500±50V and within 60±5 s of charging.			
6	Capacitar	nce	Within the specified tolerance.	The capacitance/D.F. shall be measured at 20°C at a frequency of			
7	Dissipation Factor (D.		0.025 max.	1±0.2kHz and a voltage of 1±0.2V (r.m.s.)  •Pretreatment  Perform a heat treatment at 150±₁8°C for 60±5 min and then let sit for 24±2 h at room condition.			
8	Capacitance 8 Temperature Characteristics		Cap. Change Within ±10%	The range of capacitance change compared with the 20°C value within $-25$ to $+85$ °C shall be within the specified range. •Pretreatment Perform a heat treatment at $150^{+}_{-1}$ °C for $60\pm5$ min and then let sit for $24\pm2$ h at room condition.			
9	Discharge Test (Application: Nominal Capacitance C<10,000pF)		No defects or abnormalities.	As in Fig., discharge is made 50 times at 5 s intervals from the capacitor(Cd) charged at DC voltage of specified.  R3  R1  Ct: Capacitor under test Cd: 0.001μF  R1: 1,000Ω R2: 100ΜΩ R3: Surge resistance			
10	O Adhesive Strength of Termination		No removal of the terminations or other defects shall occur.	Solder the capacitor to the testing jig (glass epoxy board) shown in Fig.1 using a eutectic solder. Then apply 10N force in the direction of the arrow. The soldering shall be done either with an iron or using the reflow method and shall be conducted with care so that the soldering is uniform and free of defects such as heat shock.  10N, 10±1s Speed: 1.0mm/s Glass Epoxy Board  Fig.1			
		Appearance	No defects or abnormalities.	Solder the capacitor to the test jig (glass epoxy board).			
		Capacitance	Within the specified tolerance.	The capacitor shall be subjected to a simple harmonic motion			
11	Vibration Resistance	D.F.	0.025 max.	having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, shall be traversed in approximately 1 min. This motion shall be applied for a period of 2 h in each 3 mutually perpendicular directions (total of 6 h).  Solder resist  Glass Epoxy Board			

"Room condition" Temperature : 15 to 35°C, Relative humidity : 45 to 75%, Atmosphere pressure : 86 to 106kPa





### **Specifications and Test Methods**

Continued from the preceding page.

Continued from the preceding page.												
. Ite	em		S	pecification	n				Test Method			
		No cracking or	marking de	fects shall c	occur.		in diı	Fig.2 using rection show	a eutectic solder. Then apply n in Fig. 3. The soldering sha	a force in the		
					φ4.5		ca	care so that the soldering is uniform and free of defects such as heat shock. $_{20}\ ^{50}\ {\rm Pressurizing}$				
Deflection		100 t: 1.6						R230 Pressurize				
		L×W		Dimens	ion (mm)				Flexur	re=1		
		(mm)	a	b	С	d			Capacitance meter	(***		
						1.0			45 45	(in mm)		
		3.17(3.0	1 4.5	Fig.2	3.0				Fig.3			
							lm	merse the c	apacitor in a solution of etha	nol (JIS-K-8101) and		
	•	75% of the termi	inations are	to he soldere	ed evenly and	d continuously				• •		
Terminati	ion	7070 01 110 101111	induoris die	to be soldere	od everily disk	a continuousiy.				.5 s at 235±5℃.		
	A	Na madia a daf					- ""	inicising spe	. 23_2.5Hilly5			
			ects.									
Change VVIUIIII ±15%							•		-			
Insulation	D.F.							90 to 98% for 8 h, and then removed in room condition for 16 h				
	I.R.	More than 1,00	0ΜΩ				ur	illi 5 cycles.				
	Dielectric Strength Pass the item No.4.											
Appearance No marking defects.						•	1					
	Capacitance Change	Within ±10%					10	±1 s. Let si	it at room condition for 24±2			
Docietance	D.F.	0.025 max.					Pretreatment					
	I.R.	More than 2,00	0ΜΩ					Perform a heat treatment at $150^{+}_{-10}^{\circ}$ °C for $60\pm5$ min and then let sit for $24\pm2$ h at room condition.				
Heat						*Preheating						
		Pass the item N	No.4.					Step	Temperature	Time		
	Outerigui									1 min 1 min		
										<u>'</u>		
	Appearance	No marking def	tects.					-		s epoxy board) shown		
		Within ±7.5%					Pe	erform the fiv	ve cycles according to the fou	ur heat treatments		
	_	0.025 may							9			
			0140						· · · · · · · · · · · · · · · · · · ·	Time (min)		
	I.K.	More than 2,00	IOINIZZ				_	1		30±3		
								2	Room Temp.	2 to 3		
										30±3 2 to 3		
Temperature Cycle	Dielectric						Perform a heat treatment at 150±18 ℃ for 60±5 min and then let sit for 24±2 h at room condition.					
	Strength	Pass the item No.4.			Ezza Ezza Ezza Ezza Ezza Ezza Ezza Ezza							
	Solderab Terminati  Humidity Insulation  Resistance to Soldering Heat	Deflection  Solderability of Termination  Humidity Insulation  Appearance Capacitance Change D.F. I.R. Dielectric Strength  Appearance Capacitance Change D.F. I.R.  Dielectric Strength  I.R.  Appearance Capacitance Change D.F. I.R.  Temperature Cycle Dielectric Dielectric	Deflection    LXW (mm)	No cracking or marking decorated by the composition of the termination   No marking defects.	Deflection   LXW   Dimens (mm)   a   b   5.7×2.8   4.5   8.0   5.7×5.0   4.5   8.0   5.7×5.0   4.5   8.0   Fig.2	Deflection   De	Deflection   De	Deflection   De	Deflection   De	Deflection   D		

"Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmosphere pressure: 86 to 106kPa





### Specifications and Test Methods

Continued from the preceding page.

No.	Ite	em	Specification	Test Method				
		Appearance	No marking defects.					
	Humidity	Capacitance Change	Within ±15%	Sit the capacitor at 40±2°C and relative humidity 90 to 95% 500±26 h.				
7	(Steady	Steady D.F. 0.05 may		Remove and let sit for 24±2 h at room condition, then measure Pretreatment				
	State)	I.R.	More than 1,000M $\Omega$	Perform a heat treatment at 150 <sup>+</sup> <sub>10</sub> °C for 60±5 min and				
		Dielectric Strength	Pass the item No.4.	let sit for 24±2 h at room condition.				
		Appearance	No marking defects.	Apply voltage and time as Table at 85±2℃. Remove and le				
		Capacitance Change	Within ±15%	for 24 $\pm$ 2 h at room condition, then measure. The charge / discharge current is less than 50mA.				
		D.F. 0.05 max.		Nominal Capacitance Test Time Test voltag  C≥10,000pF 1,000 <sup>±48</sup> h AC300V (r.m.:				
8	Life	I.R.	More than 1,000MΩ	C<10,000pF 1,500= 6 h AC500V (r.m.s				
	Liic	Dielectric Strength  Dielectric Strength  Dielectric Strength		<ul> <li>* Except that once each hour the voltage is increased to AC1,000V (r.m.s.) for 0.1 s</li> <li>•Pretreatment         Apply test voltage for 60±5 min at test temperature.         Remove and let sit for 24±2 h at room condition.     </li> </ul>				
		Appearance	No marking defects.					
		Capacitance Change	Within ±15%	Apply the rated voltage at 40±2°C and relative humidity 90 95% for 500±24 h.				
9	Humidity Loading	D.F.	0.05 max.	Remove and let sit for 24±2 h at room condition, then measured.  •Pretreatment				
	Loading	I.R.	More than 1,000M $\Omega$	Apply test voltage for 60±5 min at test temperature.				
		Dielectric Strength	Pass the item No.4.	Remove and let sit for 24±2 h at room condition.				

<sup>&</sup>quot;Room condition" Temperature : 15 to 35°C, Relative humidity : 45 to 75%, Atmosphere pressure : 86 to 106kPa



### Safety Standard Recognized Type GC (UL, IEC60384-14 Class X1/Y2)

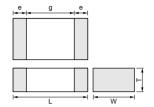
#### ■ Features

- 1. Chip monolitic ceramic capacitor (certified as conforming to safety standards) for AC line.
- 2. A new monolithic structure for small, highcapacitance capable of operating at high-voltage levels.
- 3. Compared to lead type capacitors, this new capacitor is greatly downsized and low-profiled to 1/10 or less in volume, and 1/4 or less in height.
- 4. The type GB can be used as an X2-class capacitor.
- 5. The type GC can be used as an X1-class and Y2-class capacitor.
- 6. +125 degree C guaranteed.
- 7. Only for reflow soldering.

#### ■ Applications

- Ideal use as Y capacitor or X capacitor for various switching power supply.
- Ideal use as linefilter for MODEM.





Part Number	Dimensions (mm)							
Part Number	L W		Т	e min.	g min.			
GA355D	5.7 ±0.4	5.0 ±0.4	2.0 ±0.3	0.3	4.0			
GA355X	5.7 ±0.4	5.0 ±0.4	2.7 ±0.3	0.5				

#### ■ Standard Recognition

	Standard No.	Status of R	Recognition	Rated	
	Standard No.	Type GB		Voltage	
UL	UL1414	_	©*		
BSI		_	0		
VDE	<b>5</b> 1400400	0	0	AC250V	
SEV	EN132400	0	0	(r.m.s.)	
SEMKO		0	0		
EN132400 Class		X2	X1, Y2		

\*: Line By Pass only

Part Number	Rated Voltage (V)	TC Code	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g (mm)	Electrode e (mm)
GA355DR7GC101KY02L	AC250 (r.m.s.)	X7R	100 +10,-10%	5.7	5.0	2.0	4.0 min.	0.3 min.
GA355DR7GC151KY02L	AC250 (r.m.s.)	X7R	150 +10,-10%	5.7	5.0	2.0	4.0 min.	0.3 min.
GA355DR7GC221KY02L	AC250 (r.m.s.)	X7R	220 +10,-10%	5.7	5.0	2.0	4.0 min.	0.3 min.
GA355DR7GC331KY02L	AC250 (r.m.s.)	X7R	330 +10,-10%	5.7	5.0	2.0	4.0 min.	0.3 min.
GA355DR7GC471KY02L	AC250 (r.m.s.)	X7R	470 +10,-10%	5.7	5.0	2.0	4.0 min.	0.3 min.
GA355DR7GC681KY02L	AC250 (r.m.s.)	X7R	680 +10,-10%	5.7	5.0	2.0	4.0 min.	0.3 min.
GA355DR7GC102KY02L	AC250 (r.m.s.)	X7R	1000 +10,-10%	5.7	5.0	2.0	4.0 min.	0.3 min.
GA355DR7GC152KY02L	AC250 (r.m.s.)	X7R	1500 +10,-10%	5.7	5.0	2.0	4.0 min.	0.3 min.
GA355DR7GC222KY02L	AC250 (r.m.s.)	X7R	2200 +10,-10%	5.7	5.0	2.0	4.0 min.	0.3 min.
GA355DR7GC332KY02L	AC250 (r.m.s.)	X7R	3300 +10,-10%	5.7	5.0	2.0	4.0 min.	0.3 min.
GA355DR7GC472KY02L	AC250 (r.m.s.)	X7R	4700 +10,-10%	5.7	5.0	2.0	4.0 min.	0.3 min.



### Safety Standard Recognized Type GD (IEC60384-14 Class Y3)

#### ■ Features

- A new monolithic structure for small, highcapacitance capable of operating at high-voltage levels
- 2. The type GD can be used as an Y3-class capacitor, and the type GF can be used as an Y2-class capacitor.
- 3. Available for the equipment based on IEC/EN60950 and UL1950.
- 4. +125 degree C guaranteed.
- 5. Only for reflow soldering.

#### ■ Applications

- Ideal use on line filter and coupling for transformer-less DAA modem.
- Ideal use on line filter for information equipment.



Part Number	Dimensions (mm)							
Part Number	L	W	Т	e min.	g min.			
GA342D	4.5 ±0.3	2.0 ±0.2	2.0 ±0.3					
GA343D	4.5 ±0.4	3.2 ±0.3	$2.0\pm^{0}_{0.3}$	0.3	Type GD : 2.5			
GA352D	5.7 ±0.4	2.8 ±0.3	$2.0\pm^{0}_{0.3}$	0.3	Type GF: 3.5			
GA355D	5.7 ±0.4	5.0 ±0.4	$2.0\pm^{0}_{0.3}$					

#### ■ Standard Recognition

	Standard No.	Status of R	Rated	
	Standard No.	Type GD	Type GF	Voltage
SEMKO	EN132400	0	0	AC250V
EN132400 Class		Y3	Y2	(r.m.s.)

Part Number	Rated Voltage (V)	TC Code	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g (mm)	Electrode e (mm)
GA342DR7GD101KW02L	AC250 (r.m.s.)	X7R	100 +10,-10%	4.5	2.0	2.0	2.5 min.	0.3 min.
GA342DR7GD151KW02L	AC250 (r.m.s.)	X7R	150 +10,-10%	4.5	2.0	2.0	2.5 min.	0.3 min.
GA342DR7GD221KW02L	AC250 (r.m.s.)	X7R	220 +10,-10%	4.5	2.0	2.0	2.5 min.	0.3 min.
GA342DR7GD471KW02L	AC250 (r.m.s.)	X7R	470 +10,-10%	4.5	2.0	2.0	2.5 min.	0.3 min.
GA342DR7GD102KW02L	AC250 (r.m.s.)	X7R	1000 +10,-10%	4.5	2.0	2.0	2.5 min.	0.3 min.
GA342DR7GD152KW02L	AC250 (r.m.s.)	X7R	1500 +10,-10%	4.5	2.0	2.0	2.5 min.	0.3 min.
GA343DR7GD182KW01L	AC250 (r.m.s.)	X7R	1800 +10,-10%	4.5	3.2	2.0	2.5 min.	0.3 min.
GA343DR7GD222KW01L	AC250 (r.m.s.)	X7R	2200 +10,-10%	4.5	3.2	2.0	2.5 min.	0.3 min.



### Safety Standard Recognized Type GF (IEC60384-14 Class Y2)

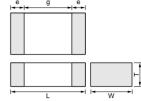
#### ■ Features

- A new monolithic structure for small, highcapacitance capable of operating at high-voltage levels
- 2. The type GD can be used as an Y3-class capacitor, and the type GF can be used as an Y2-class capacitor.
- 3. Available for the equipment based on IEC/EN60950 and UL1950.
- 4. +125 degree C guaranteed.
- 5. Only for reflow soldering.

#### ■ Applications

- Ideal use on line filter and coupling for transformer-less DAA modem.
- Ideal use on line filter for information equipment.





Part Number		Dir	mensions (	mm)	
Part Number	L	W	T	e min.	g min.
GA342D	4.5 ±0.3	2.0 ±0.2	2.0 ±0.3		
GA343D	4.5 ±0.4	3.2 ±0.3	$2.0\pm^{0}_{0.3}$	0.3	Type GD : 2.5
GA352D	5.7 ±0.4	2.8 ±0.3	$2.0\pm^{0}_{0.3}$	0.3	Type GF: 3.5
GA355D	5.7 ±0.4	5.0 ±0.4	$2.0\pm^{0}_{0.3}$		

#### ■ Standard Recognition

	Standard No.	Status of R	Rated		
	Standard No.	Type GD	Type GF	Voltage	
SEMKO	EN132400	0	0	AC250V	
EN132	400 Class	Y3	Y2	(r.m.s.)	

Part Number	Rated Voltage (V)	TC Code	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g (mm)	Electrode e (mm)
GA352DR7GF102KW01L	AC250 (r.m.s.)	X7R	1000 +10,-10%	5.7	2.8	2.0	3.5 min.	0.3 min.
GA355DR7GF222KW01L	AC250 (r.m.s.)	X7R	2200 +10,-10%	5.7	5.0	2.0	3.5 min.	0.3 min.



### Safety Standard Recognized Type GB (IEC60384-14 Class X2)

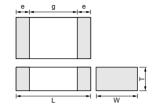
#### ■ Features

- 1. Chip monolitic ceramic capacitor (certified as conforming to safety standards) for AC line.
- 2. A new monolithic structure for small, highcapacitance capable of operating at high-voltage levels.
- 3. Compared to lead type capacitors, this new capacitor is greatly downsized and low-profiled to 1/10 or less in volume, and 1/4 or less in height.
- 4. The type GB can be used as an X2-class capacitor.
- 5. The type GC can be used as an X1-class and Y2-class capacitor.
- 6. +125 degree C guaranteed.
- 7. Only for reflow soldering.

#### ■ Applications

- Ideal use as Y capacitor or X capacitor for various switching power supply.
- Ideal use as linefilter for MODEM.





Part Number	Dimensions (mm)						
Part Number	L	W	Т	e min.	g min.		
GA355D	5.7 ±0.4	5.0 ±0.4	2.0 ±0.3	0.3	4.0		
GA355X	5.7 ±0.4		2.7 ±0.3	0.3			

#### ■ Standard Recognition

	Standard No.	Status of R	Rated	
			Type GC	Voltage
UL	UL1414	_	©*	
BSI	EN132400	_	0	
VDE		0	0	AC250V
SEV		0	0	(r.m.s.)
SEMKO		0	0	
EN132	400 Class	X2	X1, Y2	

\*: Line By Pass only

Part Number	Rated Voltage (V)	TC Code	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g (mm)	Electrode e (mm)
GA355DR7GB103KY02L	AC250 (r.m.s.)	X7R	10000 +10,-10%	5.7	5.0	2.0	4.0 min.	0.3 min.
GA355DR7GB153KY02L	AC250 (r.m.s.)	X7R	15000 +10,-10%	5.7	5.0	2.0	4.0 min.	0.3 min.
GA355DR7GB223KY02L	AC250 (r.m.s.)	X7R	22000 +10,-10%	5.7	5.0	2.0	4.0 min.	0.3 min.
GA355XR7GB333KY06L	AC250 (r.m.s.)	X7R	33000 +10,-10%	5.7	5.0	2.7	4.0 min.	0.3 min.



### **GA3 Series Specifications and Test Methods**

No.	Ite	em	Specification	Test Method
1	Operating Temperatu	ıre Range	−55 to +125°C	_
2	Appearar	nce	No defects or abnormalities.	Visual inspection.
3	Dimensio	ns	Within the specified dimensions.	Using calipers.
4	Dielectric Strength		No defects or abnormalities.	No failure shall be observed when voltage as table is applied between the terminations for 60±1 s, provided the charge/discharge current is less than 50mA.  Test voltage Type GB DC1075V Type GC/GD/GF AC1500V (r.m.s.)
5	Insulation I	Resistance	More than $6,000M\Omega$	The insulation resistance shall be measured with 500±50V and within 60±5 s of charging.
6	Capacita	nce	Within the specified tolerance.	The capacitance/D.F. shall be measured at 20℃ at a frequency of
7	Dissipation Factor (D		0.025 max.	1±0.2kHz and a voltage of 1±0.2V (r.m.s.)  •Pretreatment  Perform a heat treatment at 150±₁8°C for 60±5 min and then let sit for 24±2 h at room condition.
8	Capacitance Temperature Characteristics		Cap. Change Within ±15%	The range of capacitance change compared with the 25°C value within −55 to +125°C shall be within the specified range.  •Pretreatment Perform a heat treatment at 150±₁°C for 60±5 min and then let sit for 24±2 h at room condition.
		Appearance	No defects or abnormalities.	As in Fig., discharge is made 50 times at 5 s intervals from
		I.R.	More than 1,000MΩ	the capacitor(Cd) charged at DC voltage of specified.
9	Discharge Test (Application: Type GC)	Dielectric Strength	Pass the item No.4.	R3  T 10kV  Ct : Capacitor under test Cd : 0.001μF  R1 : 1,000Ω R2 : 100MΩ R3 : Surge resistance
10	Adhesive Strength of Termination		No removal of the terminations or other defect shall occur.	Solder the capacitor to the testing jig (glass epoxy board) shown in Fig.1 using a eutectic solder. Then apply 10N force in the direction of the arrow. The soldering shall be done either with an iron or using the reflow method and shall be conducted with care so that the soldering is uniform and free of defects such as heat shock.  10N, 10±1s Speed: 1.0mm/s Glass Epoxy Board  Fig.1
		Appearance	No defects or abnormalities.	Solder the capacitor to the test jig (glass epoxy board).
		Capacitance	Within the specified tolerance.	The capacitor shall be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied
11	Vibration Resistance	D.F.	0.025 max.	uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, shall be traversed in approximately 1 min. This motion shall be applied for a period of 2 h in each 3 mutually perpendicular directions (total of 6 h).

"Room condition" Temperature : 15 to 35°C, Relative humidity : 45 to 75%, Atmosphere pressure : 86 to 106kPa





### GA3 Series Specifications and Test Methods

Continued from the preceding page.

No.				Test Method		
12	12 Deflection		No cracking or marking defects shall occur.	Solder the capacitor to the testing jig (glass epoxy board) shown in Fig.2 using a eutectic solder. Then apply a force in the direction shown in Fig. 3. The soldering shall be done either with an iron or using the reflow method and shall be conducted with care so that the soldering is uniform and free of defects such as heat shock.  20 50 Pressurizing speed: 1.0mm/s Pressurize  Pressurize  Flexure=1  Capacitance meter  (in mm)  Fig.3		
13	Solderability of Termination		75% of the terminations is to be soldered evenly and continuously.	Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion). Immerse in eutectic solder solution for 2±0.5 s at 235±5°C. Immersing speed: 25±2.5mm/s		
14	Resistance to Soldering Heat	Appearance Capacitance Change I.R.	No marking defects. Within $\pm 10\%$ More than $1{,}000\text{M}\Omega$	Preheat the capacitor as table. Immerse the capacitor in eutectic solder solution at 260±5°C for 10±1 s. Let sit at room condition for 24±2 h, then measure.  •Immersing speed: 25±2.5mm/s  •Pretreatment  Perform a heat treatment at 150±18°C for 60±5 min and then let sit for 24±2 h at room condition.		
	пеац	Dielectric Strength	Pass the item No.4.	Step         Temperature         Time           1         100℃ to 120℃         1 min.           2         170℃ to 200℃         1 min.		
		Appearance Capacitance Change D.F. I.R.	No marking defects. Within $\pm 15\%$ 0.05 max. More than $3{,}000\text{M}\Omega$	Fix the capacitor to the supporting jig (glass epoxy board) shown in Fig.4 using a eutectic solder.  Perform the five cycles according to the four heat treatments listed in the following table.  Let sit for 24±2 h at room condition, then measure.  Step Temperature (°C) Time (min)  1 Min. Operating Temp.±3 30±3  2 Room Temp. 2 to 3  3 Max. Operating Temp.±2 30±3		
15	Temperature Cycle	Dielectric Strength	Pass the item No.4.	Pretreatment Perform a heat treatment at 150 <sup>+</sup> <sub>1</sub> ° ℃ for 60±5 min and then let sit for 24±2 h at room condition.  Glass Epoxy Board  Fig.4		
		Appearance	No marking defects.	1 ig		
	Humidity	Capacitance Change	Within ±15%	Sit the capacitor at 40±2℃ and relative humidity 90 to 95% for		
16	(Steady State)	D.F.	0.05 max.	500±12 h.  Remove and let sit for 24±2 h at room condition, then measure.		
	,	I.R. Dielectric Strength	More than $3,000M\Omega$ Pass the item No.4.			

"Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmosphere pressure: 86 to 106kPa





### **GA3 Series Specifications and Test Methods**

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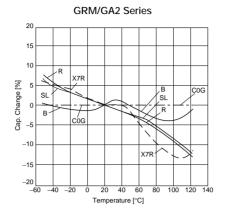
No.	Ite	em	Specification	Test Method
17		Appearance Capacitance Change	No marking defects.  Within ±20%	Impulse Voltage Each individual capacitor shall be subjected to a 2.5kV (Type GC/GF:5kV)Impulses (the voltage
		D.F.	0.05 max.	value means zero to peak) for three
		I.R.	More than $3,000M\Omega$	times. Then the capacitors are applied to life test.
	Life	Dielectric Strength	Pass the item No.4.	Apply voltage as Table for 1,000 h at 125 ± 3 °C, relative humidity 50% max.  Type Applied voltage  GB AC312.5V (r.m.s.), except that once each hour the voltage is increased to AC1,000V (r.m.s.) for 0.1s.  GC GD AC425V (r.m.s.), except that once each hour the voltage is increased to AC1,000V (r.m.s.) for 0.1s.
		Appearance	No marking defects.	
		Capacitance Change	Within ±15%	Apply the rated voltage at 40±2°C and relative humidity 90 to
18	Humidity Loading	D.F.	0.05 max.	95% for 500 <sup>+24</sup> h. Remove and let sit for 24±2 h at room
	Localing	I.R.	More than $3,000\text{M}\Omega$	condition, then measure.
		Dielectric Strength	Pass the item No.4.	

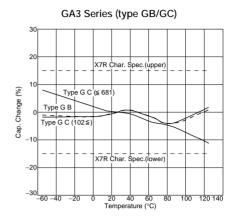
<sup>&</sup>quot;Room condition" Temperature : 15 to 35℃, Relative humidity : 45 to 75%, Atmosphere pressure : 86 to 106kPa

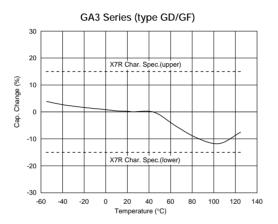


### GRM/GA2/GA3 Series Data (Typical Example)

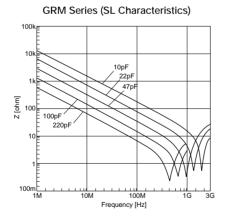
#### **■** Capacitance-Temperature Characteristics

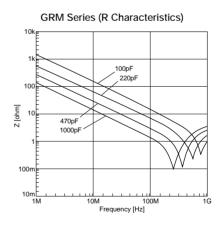






#### ■ Impedance-Frequency Characteristics







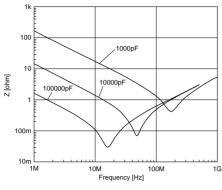


# GRM/GA2/GA3 Series Data (Typical Example)

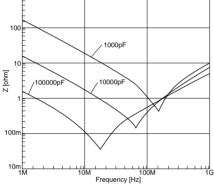
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### ■ Impedance-Frequency Characteristics

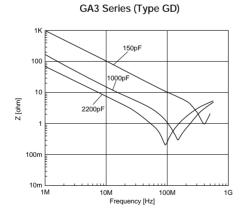
GRM Series (X7R Char. 250V)



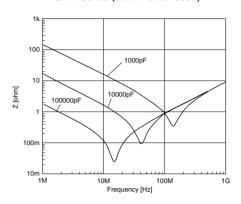


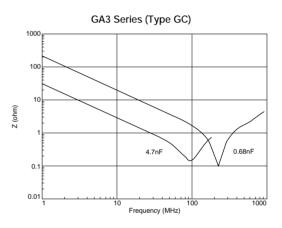


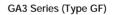
**GA2 Series** 

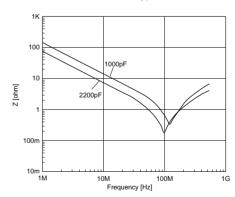


#### GRM Series (B/X7R Char. 630V)











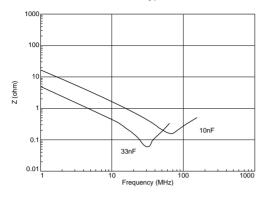


### GRM/GA2/GA3 Series Data (Typical Example)

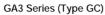
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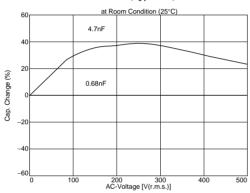
#### ■ Impedance-Frequency Characteristics

GA3 Series (Type GB)



### ■ Capacitance-AC Voltage Characteristics





#### GA3 Series (Type GD/GF)

